

Search Notes

Application/Control No.

10/522,577

Examiner

Chau N. Nguyen

Applicant(s)/Patent under
Reexamination

TAKAHASHI ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
174	106R	12/16/2005	CN
	108		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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